

Application/Control No.	Applicant(s)/Patent under Reexamination SEKI ET AL.	
TAN TRINH	2684	

SEARCHED				
Class	Subclass	Date	Examiner	
455	450	5/22/2006	π	
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST	5/22/2006 8/26/06	π		
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NGUYEN VO	5/22/2006	π		
INTEATERENCE Sear CR	8/30/06	7.7		